Enhanced Vortex Pinning in Annealed TlBa₂CaCu₂O_x Thin Films

Eugene L. Venturini, Paula P. Newcomer, Michael P. Siegal and Donald L. Overmyer Sandia National Laboratories, Albuquerque, NM 87185-1421

Abstract—Furnace anneals of $TlBa_2CaCu_2O_x$ thin films at temperatures above 500°C cause partial TlO_x loss. Highresolution transmission electron microscopy images reveal nanometer-scale discontinuities (pinched stacking faults) in the microstructure of annealed films. Significant increases in the vortex pinning potential and critical current density at elevated temperatures in strong magnetic fields are observed and are attributed to the presence of these localized defects.

I. INTRODUCTION

Many applications of high-temperature superconducting (HTS) thin films require large current densities J in high magnetic fields B at elevated temperatures. Under these conditions, the field penetrates the material via discrete, quantized magnetic vortices and the vortices experience a strong Lorentz force J×B. Early experiments on HTS cuprates showed that the vortices are weakly pinned [1,2]. Hence, the substantial thermal energy causes "giant flux creep" and the resulting large dissipation. Maintaining high J values under these conditions requires the incorporation of lattice defects or secondary phases to pin the vortices, thus suppressing their motion.

Modest improvements in vortex pinning were achieved by creating *localized defects* through irradiation with fast neutrons [3,4] or high-energy light ions [5]. Strong vortex pinning in HTS materials was demonstrated for *extended defects* introduced in YBa₂Cu₃O_{7- δ} single crystals by highenergy, heavy-ion irradiation [6,7]. Detailed structural studies confirmed that the pinning sites were amorphous, linear damage tracks produced by these heavy ions [8]. For Tl-based superconductors, both bulk ceramics [9] and thin films [10] showed strongly enhanced vortex pinning when extended defects were incorporated.

We have recently reported that the superconducting properties of TlBa₂CaCu₂O_x (Tl-1212) thin films can be enhanced by annealing in nitrogen at temperatures from 250 to 600°C [11]. These reducing anneals raise the superconducting transition temperature T_c from ~70 K for films as-grown in one atm oxygen to ~95 K. In addition, the low-field critical current density J_{cm} measured by magnetic hysteresis increases significantly after annealing in nitrogen above 500°C. The maximum J_{cm} at 5 K in self-

field was $1(\pm 0.2) \times 10^7$ A/cm² following a one-hour nitrogen anneal at 600°C, ~50% higher than the J_{cm} for as-grown films [11].

These enhanced properties are attributed to partial TIO_x loss suggested by energy dispersive x-ray compositional analyses comparing the as-grown and high-temperatureannealed films [12]. Cross-sectional, phase-contrast, high-resolution transmission electron microscope (HRTEM) images show two types of disorder in annealed films, circular regions of contrast modulation on a 100 nm scale and pinched stacking faults on a 1 nm scale surrounded by lattice disorder extending for 2-10 nm. The latter microstructural defects are ideal in size for vortex pinning. Hence, simple furnace annealing offers a promising technique for creating controlled, nanometer-scale microstructural damage that enhances the superconducting properties of these films.

In this paper we report new annealing studies and magnetization measurements on Tl-1212 films. The annealing produces significant increases in both J_{cm} for large magnetic fields and the vortex pinning potential $U_{eff}(J,T)$ for large current densities J at elevated temperatures T.

II. EXPERIMENTAL DETAILS

Thin films (~600 nm) of Tl-1212 are grown in one atm oxygen in a two-zone furnace using an amorphous BaCaCuO precursor on a single crystal (100) LaAlO₃ substrate [13]. The resulting films are nearly phase pure and highly oriented with the crystallographic c-axis normal to the substrate. Post-growth anneals at 600°C in flowing nitrogen using the same two-zone furnace produce a significant enhancement in both T_c and J_{cm} [11].

However, new annealing studies in a separate tube furnace in flowing nitrogen showed that 600° C produces excessive TIO_x loss and destroys the superconductivity in these films. The discrepancy arose from the presence of Tl₂O₃ condensed on the walls of the two-zone furnace from prior film growth. This condensed material provided an internal, unrecognized source of both oxygen and TlO_x during our initial high-temperature anneals in flowing nitrogen. Recent measurements using an oxygen sensor show that the oxygen partial pressure at the film is ~0.01 atm during the 600° C "nitrogen" anneal in the two-zone furnace when condensed Tl₂O₃ is present.

This paper compares the superconducting properties of films before and after one-hour, high-temperature anneals

Manuscript received August 26, 1996.

This work was performed at Sandia National Laboratories and supported by the U. S. Department of Energy, Office of Basic Energy Sciences, under Contract No. DE-AC04-94AL85000.

in a tube furnace using two distinct flowing gases: 100% oxygen and 10% oxygen in nitrogen. These experiments produced improvements in T_c and J_{cm} comparable to those observed for the two-zone annealed films, but with optimum annealing temperatures near 685°C in 100% oxygen and 630°C in 10% oxygen. Anneals in lower oxygen partial pressures are in progress and will be reported elsewhere.

Magnetic measurements were performed with a commercial SQUID magnetometer (Quantum Design MPMS). The superconducting transition temperature T_c was determined from the Meissner signal (field cooling) in a 0.2 mT field applied normal to the film (i.e., along the crystallographic c-axis). J_{cm} was calculated from isothermal hysteresis loops and the vortex pinning potential was extracted from isothermal flux creep data.

III. ENHANCED SUPERCONDUCTING PROPERTIES

Several films were annealed in 100% flowing oxygen between 600 and 750°C to determine the optimum temperature (685°C) for enhanced J_{cm} and vortex pinning. These anneals lowered T_c to between 70 and 80 K, similar to the T_c's for the films as-grown in oxygen. Hence, a subsequent reducing anneal at 250°C in flowing nitrogen was added to raise T_c to its maximum value before additional J_{cm} studies. Anneals below 700°C in 100% oxygen plus 250°C in nitrogen did not change J_{cm} in selffield at 5 K by more than the 5% experimental error; T_c ranged from 88 to 90 K for these films. Anneals at 700°C or higher in 100% oxygen plus 250°C nitrogen caused a systematic decrease in both T_c and J_{cm} at 5 K in self-field. The highest temperature anneal (750°C) lowered T_c to 80 K, broadened the Meissner transition, and decreased J_{cm} by 75%. Though anneals below 700°C in 100% oxygen did not change J_{cm} in self-field, they did increase vortex pinning and $J_{\mbox{\tiny cm}}$ in large magnetic fields at temperatures to $60~\mbox{K}$ with the optimal annealing temperature being $685(\pm 10)^{\circ}$ C.

Similarly, several films where annealed in 10% oxygen in flowing nitrogen between 600 and 650°C to determine the optimum temperature (630° C) for enhanced J_{cm} and vortex pinning. A subsequent reducing anneal at 250°C was not beneficial since T_o was maximized between 88 and 90 K after the 10% oxygen anneal. Anneals at 600 and 650°C in 10% oxygen changed J_{cm} in self-field at 5 K by less than 5% while anneals between 625 and 635°C increased J_{cm} between 10 and 30%. More importantly, the greatest enhancement in hysteresis and vortex pinning at temperatures to 60 K was observed for these latter anneals, suggesting that $630(\pm 10)^{\circ}$ C is optimum for 10% oxygen anneals.

Fig. 1 compares the Meissner transition in three annealed films: (1) after a low-temperature reducing anneal (one hour at 250° C in flowing nitrogen, open triangles), (2) after a high-temperature anneal (one hour at 630° C in 10%



Fig. 1. Meissner transition (field cooling) for three Tl-1212 films. The high-temperature anneal suppresses T_c by ~5%.

The low-temperature nitrogen anneal increases T_c to ~94 K (typical for our TI-1212 films grown at 800°C in a twozone furnace) [13]. Both of the high-temperature oxygen anneals (100% and 10%) reduce T_c by 4 K to ~90 K, but yield a slightly sharper transition in 0.2 mT. Note that the 100% oxygen anneal was followed by a 250°C anneal in nitrogen. The sharp Meissner transitions suggest that the high-temperature anneals and accompanying TIO_x loss do not result in a macroscopically nonuniform carrier concentration with a distribution of T_c values or a preferential degradation at grain boundaries. However, there is evidence in the HRTEM cross-sectional images that between 20 and 30% of the upper (free surface) part of the film is structurally disordered following the oxygen anneal. The current density values in the annealed films were calculated using its original thickness, ignoring any structural changes that affect supercurrents near the surface.

The remainder of this section compares J_{cm} and the vortex pinning potential of a TI-1212 film annealed first at 250°C in nitrogen and subsequently at 630°C for one hour in 10% oxygen. (Comparable enhancements in the superconducting properties were measured for another film annealed at 685°C in 100% oxygen followed by 250°C in nitrogen.) At 5 K in self-field J_{cm}, determined from magnetic hysteresis using the Bean critical state model and the dimensions of the entire sample with appropriate geometric corrections [14], increased from 6×10^6 A/cm² after the 250°C nitrogen anneal to 8×10^6 A/cm² after the 630°C anneal. Further, J_{cm} was higher at all field strengths to 5 tesla at 5 K following the 630°C anneal. Fig. 2 compares J_{cm} versus field at 40 K before and after the $630^{\circ}C$ anneal. The marked increase in J_{cm} at higher fields indicates that the structural changes accompanying hightemperature anneals provide strong pinning sites for vortices. Hysteresis loops at 20 and 60 K also show higher J_{cm} after the 630°C anneal.



Fig. 2. Critical current density J_{em} at 40 K versus applied magnetic field from hysteresis loops measured before and after a 630 °C anneal in a 10% oxygen atmosphere.

The increased vortex pinning that supports the higher J_{cm} can be shown directly by calculating the pinning force density F_p versus applied field from the data in Fig 2. The critical current density J_{cm} for a given induction field B is reached when the Lorentz force density on the vortices, $J_{cm} \times B$, balances the pinning force density F_p . The log-log plot in Fig. 3 emphasizes the additional pinning attributed to the microstructural defects in the annealed film. Both the magnitude and position of the peak in F_p and the rapid decrease approaching the irreversibility line are shifted to considerably higher field strengths after annealing.



Fig. 3. Vortex pinning force density $F_{\rm p}$ versus applied magnetic field at 40 K before and after 630 $^{\circ}{\rm C}$ anneal.

Additional confirmation of the enhanced pinning after high-temperature annealing is the comparison of effective vortex pinning potentials $U_{eff}(J,T)$ versus current density J shown in Fig. 4. These data are calculated from a series of isothermal magnetic relaxation measurements in a fixed field (one tesla applied normal to the film for Fig. 4). The creep experiment involves cooling from above T_{o} to the measurement temperature in zero field, applying the desired field and monitoring sample moment versus time (up to two hours at each temperature). The current density J is determined from the measured moment and sample dimensions, while $U_{eff}(J,T)$ is calculated from the moment versus time using the procedure of Maley et al. [15]. Selected temperatures are indicated in the figure.



Fig. 4. Effective vortex pinning potential in one tesla versus current density before and after 630 °C anneal. Data were calculated from isothermal flux creep measurements.

The data in Fig. 4 illustrate two significant changes following the high-temperature oxygen anneal. First, the current density in one tesla at 5 K is increased by ~50%. Second, the film annealed at 630°C supports a measurable current density (irreversibility) up to 23 K in one tesla in contrast to 17 K after the 250°C anneal. More importantly, $U_{eff}(J,T)$ is increased by ~50% for current densities J in the 10^5 A/cm² range. Since the dissipation at a given field and temperature varies exponentially with U_{eff} , this increase means substantially lower losses in practical applications at elevated temperature in large fields.

IV. CONCLUDING REMARKS

We have shown that simple, low-cost furnace anneals of TI-1212 thin films in 100% oxygen or 10% oxygen in nitrogen can be used to significantly enhance both J_{cm} and vortex pinning at elevated temperatures in large magnetic fields. The microstructural changes produced by these anneals, identified by HRTEM as ~1 nm pinched stacking faults surrounded by 2-10 nm of lattice disorder, are thought to be the source of the enhanced superconducting properties. These structural changes are driven by partial TIO_x loss during the high-temperature anneals. Although the anneals cause a small decrease in T_c (~5%) compared to films annealed at 250°C in nitrogen, enhanced J_{em} is observed at all temperatures up to 60 K.

The incorporation of small secondary phase impurities has been shown to enhance the vortex pinning and J_{cm} of bulk cuprate superconductors. This was first noted for melttextured $YBa_2Cu_3O_7$ where the thermal gradient processing generated Y₂BaCuO₅ inclusions that provided pinning sites [16]. Subsequently, partial melting of single TIO_x layer produced $Tl_{0.5}Pb_{0.5}Sr_{1.6}Ba_{0.4}Ca_2Cu_3O_v$ micron-sized inclusions of (Ca,Sr)₂CuO₃ and BaPbO₃ and much larger J_{cm} values in ceramic samples. The present work differs in several respects. First, the furnace anneals involve temperatures well below any melting or decomposition events and any trace impurities are actually lowered after annealing [11]. Second, the present samples are highly oriented thin films that carry substantial macroscopic supercurrents both before and after the high-temperature anneals. And, third, the microstructural defects occur on a much smaller length scale, a few nanometers as opposed to microns, and involve stacking fault dislocations rather than secondary phases [13]. Hence, these strong pinning sites are matched closely to the in-plane coherence length for a vortex the in cuprate superconductors.

REFERENCES

- K. A. Müller, M. Takashige and J. G. Bednorz, "Flux trapping and superconductive glass state in La₂CuO_{4-y}:Ba," *Phys. Rev. Lett.*, vol. 58, pp. 1143-1146, 16 March 1987.
- [2] Y. Yeshurun and A. P. Malozemoff, "Giant flux creep and irreversibility in an Y-Ba-Cu-O crystal: an alternative to the superconducting-glass model," *Phys. Rev. Lett.*, vol. 60, pp. 2202-2205, 23 May 1988.
- [3] A. Umezawa, G. W. Crabtree, J. Z. Liu, H. W. Weber, W. K. Kwok, L. H. Nunez, T. J. Moran, C. H. Sowers and H. Claus, "Enhanced critical magnetization currents due to fast neutron irradiation in single-crystal YBa₂Cu₃O₇₋₅," *Phys. Rev. B*, vol. 36, 7151-7154, 1 November 1987.
- [4] R. B. van Dover, E. M. Gyorgy, L. F. Schneemeyer, J. W. Mitchell, K. V. Rao, R. Puzniak and J. V. Waszczak, "Critical currents near 10⁶ A cm⁻² at 77 K in neutron-irradiated single-crystal YBa²Cu³O⁷," *Nature*, vol. 342, pp. 55-57, 2 November 1989.
- [5] L. Civale, A. D. Marwick, M. W. McElfresh, T. K. Worthington, A. P.

Malozemoff, F. H. Holtzberg, J. R. Thompson and M. R. Kirk, "Defect independence of the irreversibility line in proton-irradiated Y-Ba-Cu-O crystals," *Phys. Rev. Lett.*, vol. 65, pp. 1164-1167, 27 August 1990.

- [6] L. Civale, A. D. Marwick, T. K. Worthington, M. A. Kirk, J. R. Thompson, L. Krusin-Elbaum, Y. Sun, J. R. Clem and F. Holtzberg, "Vortex confinement by columnar defects in YBa₂Cu₃O₇ crystals: enhanced pinning at high fields and temperatures," *Phys. Rev. Lett.*, vol. 67, pp. 648-651, 29 July 1991.
- [7] M. Konczykowski, F. Rullier-Albenque, E. R. Jacoby, A. Shaulov, Y. Yeshurun and P. Lejay, "Effect of 5.3-GeV Pb-ion irradiation on irreversible magnetization in Y-Ba-Cu-O crystals," *Phys. Rev. B*, vol. 44, pp. 7167-7170, 1 October 1991.
- [8] Yimei Zhu, Z. X. Cai, R. C. Budhani, M. Suenaga and D. O. Welch, "Structures and effects of radiation damage in cuprate superconductors irradiated with several-hundred-MeV heavy ions," *Phys. Rev. B*, vol. 48, pp. 6436-6450, 1 September 1993.
- [9] V. Hardy, D. Groult, J. Provost, M. Hervieu, B. Raveau and S. Bouffard, "GeV-heavy ion irradiation effects in thallium-based superconducting copper oxides," *Physica C*, vol. 178, pp. 255-265, 1 August 1991.
- [10] R. C. Budhani, M. Suenaga and S. H. Liou, "Giant suppression of fluxflow resistivity in heavy-ion irradiated Tl₂Ba₂Ca₂Cu₃O₁₀ films: influence of linear defects on vortex transport," *Phys. Rev. Lett.*, vol. 69, pp. 3816-3819, 28 December 1992.
- [11] M. P. Siegal, E. L. Venturini, P. P. Newcomer, B. Morosin, D. L. Overmyer, F. Dominguez and R. G. Dunn, "Enhancement of the superconducting properties of TlBa₂CaCu₂O₇₊₆ thin films via postannealing," *Appl. Phys. Lett.*, vol. 67, pp. 3966-3968, 25 December 1995.
- [12] P. P. Newcomer, private communication.
- [13] M. P. Siegal, E. L. Venturini, P. P. Newcomer, D. L. Overmyer, F. Dominguez and R. G. Dunn, "Importance of controlling the TI-oxide partial pressure throughout the processing of TIBa₂CaCu₂O₇₊₆ thin films," *J. Appl. Phys.*, vol. 78, pp. 7186-7191, 15 December 1995.
- [14] E. M. Gyorgy, R. B. van Dover, K. A. Jackson, L. F. Schneemeyer and J. V. Waszczak, "Anisotropic critical currents in Ba₂YCu₃O₇ analyzed using an extended Bean model," *Appl. Phys. Lett.*, vol. 55, pp. 283-285, 17 July 1989.
- [15] M. P. Maley, J. O. Willis, H. Lessure and M. E. McHenry, "Dependence of flux-creep activation energy upon current density in grain-aligned YBa₂Cu₃O_{7-x}," *Phys. Rev. B*, vol. 42, pp. 2639-2642, 1 August 1990.
- [16] S. Jin, T. H. Tiefel, R. C. Sherwood, M. E. Davis, R. B. van Dover, G. W. Kammlott, R. W. Fastnacht and H. D. Keith, "High critical currents in Y-Ba-Cu-O superconductors," *Appl. Phys. Lett.*, vol. 52, pp. 2074-2076, 13 June 1988.
- [17] T. Doi, M. Okada, A. Soeta, T. Yuasa, K. Aihara, T. Kamo and S.-P. Matsuda, "Flux pinning in single Tl-layer 1223 superconductors," Physica C, vol. 183, pp. 67-72, 10 November 1991.